

Search Notes

Application/Control No.

10/516,639

Examiner

Chau N. Nguyen

Applicant(s)/Patent under
Reexamination

BAKKA ET AL.

Art Unit

2831

SEARCHED

Class	Subclass	Date	Examiner
174	113R	7/6/2005	CN
	102R		
	106R		
336	205		
	206		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Text	7/6/2005	CN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner